. Notice of References Cited					Application/Control No. 10/534,750		Reexamination	Applicant(s)/Patent Under Reexamination FUJIKI ET AL.	
•		Notice of References Cited			Examiner Art Unit		Art Unit	B4-64	
					Jeong S. Park		2154	Page 1 of 1	
				U.S. P/	ATENT DOCUME	NTS			
		Document Number Country Code-Number-Kind Code	Date MM-YYYY		Name			Classification	
-	Α	US-6,571,278	05-2003	Negishi et al.				709/213	
-	В	US-2002/0129103	09-2002	Birkler	Birkler et al.			709/203	
	С	US-							
	D	US-							
	E	US-							
	F	US-							
	G	US-							
	н	US-							
	ı	US-							
	J	US-							
	K	US-	<u> </u>						
	L	US-							
	М	US-	<u> </u>	ļ					
				FOREIGN	PATENT DOCU	MENTS	· · · · · · · · · · · · · · · · · · ·		
	1	Document Number	Date	١ ،	Country.	Nai	me I	Classification	
_		Document Number Country Code-Number-Kind Code	MM-YYYY	<u> </u>	Country	Na			
	N		MM-YYYY		Sountry	Na	me		
_	N O		MM-YYYY		Sountry .	Na			
<u> </u>			MM-YYYY		Soundy .	Na			
	0		MM-YYYY		Soundy .	Na			
	O P Q R		MM-YYYY		Soundy .	Nai			
	O P Q R		MM-YYYY		Soundy .	Nai			
	O P Q R		MM-YYYY						
	O P Q R	Country Code-Number-Kind Code		NON-P	ATENT DOCUM	≣NTS			
	O P Q R	Country Code-Number-Kind Code		NON-P	ATENT DOCUM	≣NTS			
	O P Q R S T	Country Code-Number-Kind Code		NON-P	ATENT DOCUM	≣NTS			
	O P Q R	Country Code-Number-Kind Code		NON-P	ATENT DOCUM	≣NTS			
*	O P Q R S T	Country Code-Number-Kind Code		NON-P	ATENT DOCUM	≣NTS			
	O P Q R S T	Country Code-Number-Kind Code		NON-P	ATENT DOCUM	≣NTS			

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Х